Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,297	OHGANE ET AL.	
Examiner	Art Unit	
Tae H. Yoon	1714	

SEARCHED					
Class	Subclass	Date	Examiner		
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Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Inventor Search			
GAST	1/2/07	2	